



# LMV321, LMV358, LMV324 General Purpose, Low Voltage, Rail-to-Rail Output Amplifiers

### Features at +2.7V

- 80µA supply current per channel
- 1.2MHz gain bandwidth product
- Output voltage range: 0.01V to 2.69V
- Input voltage range: -0.25V to +1.5V
- 1.5V/µs slew rate
- LMV321 directly replaces other industry standard LMV321 amplifiers; available in SC70-5 and SOT23-5 packages
- LMV358 directly replaces other industry standard LMV358 amplifiers; available in MSOP-8 and SOIC-8 packages
- LMV324 directly replaces other industry standard LMV324 amplifiers; available in TSSOP-14 and SOIC-14 packages
- Fully specified at +2.7V and +5V supplies
- Operating temperature range: -40°C to +125°C

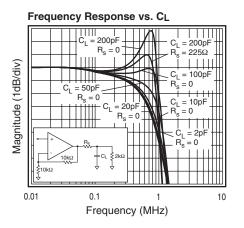
# Applications

- Low cost general purpose applications
- Cellular phones
- · Personal data assistants
- A/D buffer
- DSP interface
- Smart card readers
- Portable test instruments
- · Keyless entry
- · Infrared receivers for remote controls
- Telephone systems
- Audio applications
- Digital still cameras
- Hard disk drives
- MP3 players

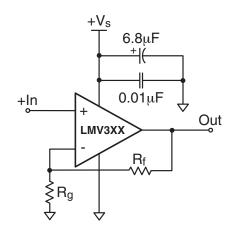
### Description

The LMV321 (single), LMV358 (dual), and LMV324 (quad) are a low cost, voltage feedback amplifiers that consume only  $80\mu$ A of supply current per amplifier. The LMV3XX family is designed to operate from 2.7V (±1.35V) to 5.5V (±2.75V) supplies. The common mode voltage range extends below the negative rail and the output provides rail-to-rail performance.

The LMV3XX family is designed on a CMOS process and provides 1.2MHz of bandwidth and  $1.5V/\mu s$  of slew rate at a low supply voltage of 2.7V. The combination of low power, rail-to-rail performance, low voltage operation, and tiny package options make the LMV3XX family well suited for use in personal electronics equipment such as cellular handsets, pagers, PDAs, and other battery powered applications.

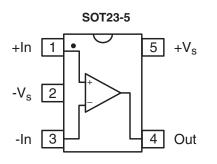


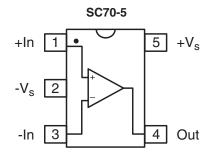
# **Typical Application**



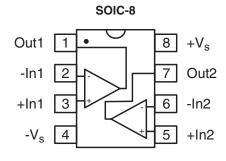
# **Pin Assignments**

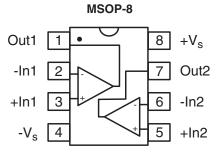
### LMV321





### LMV358





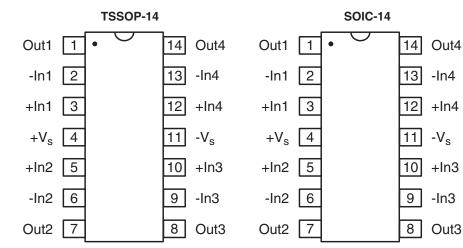
-In4

+In4

-Vs

-In3

### LMV324



### **Absolute Maximum Ratings**

Parameter	Min.	Max.	Unit
Supply Voltages	0	+6	V
Maximum Junction Temperature	_	+175	°C
Storage Temperature Range	-65	+150	°C
Lead Temperature, 10 seconds	-	+260	°C
Input Voltage Range	-V <sub>s</sub> -0.5	+V <sub>s</sub> +0.5	V

## **Recommended Operating Conditions**

Parameter	Min.	Max.	Unit
Operating Temperature Range	-40	+125	°C
Power Supply Operating Range	2.5	5.5	V

### **Electrical Specifications**

 $(T_c = 25^{\circ}C, V_s = +2.7V, G = 2, R_L = 10k\Omega \text{ to } V_s/2, R_f = 10k\Omega, V_o (DC) = V_{cc}/2; \text{ unless otherwise noted})$ 

Parameter	Conditions	Min.	Тур.	Max.	Unit
AC Performance					
Gain Bandwidth Product	$C_L = 50 \text{pF}, R_L = 2 \text{k}\Omega \text{ to } V_S/2$		1.2		MHz
Phase Margin			52		deg
Gain Margin			17		dB
Slew Rate	$V_0 = 1V_{pp}$		1.5		V/µs
Input Voltage Noise	>50kHz		36		nV/√Hz
Crosstalk: LMV358	100kHz		91		dB
LMV324	100kHz		80		dB
DC Performance					
Input Offset Voltage <sup>1</sup>			1.7	7	mV
Average Drift			8		μV/°C
Input Bias Current <sup>2</sup>			<1		nA
Input Offset Current <sup>2</sup>			<1		nA
Power Supply Rejection Ratio <sup>1</sup>	DC	50	65		dB
Supply Current (Per Channel) <sup>1</sup>			80	120	μA
Input Characteristics					
Input Common Mode Voltage Range <sup>1</sup>	LO	0	-0.25		V
	HI		1.5	1.3	V
Common Mode Rejection Ratio <sup>1</sup>		50	70		dB
Output Characteristics					
Output Voltage Swing	$R_L = 10k\Omega$ to V <sub>S</sub> /2; LO <sup>1</sup>	0.1	0.01		V
	$R_L = 10k\Omega$ to $V_s/2$ ; HI <sup>1</sup>		2.69	2.6	V

Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

#### Notes:

1. Guaranteed by testing or statistical analysis at +25°C.

2. +IN and -IN are gates to CMOS transistors with typical input bias current of <1nA. CMOS leakage is too small to practically measure.

### **Electrical Specifications**

 $(T_c = 25^{\circ}C, V_s = +5V, G = 2, R_L = 10k\Omega$  to  $V_s/2, R_f = 10k\Omega, V_o (DC) = V_{cc}/2$ ; unless otherwise noted)

Parameter	Conditions	Min.	Тур.	Max.	Unit
AC Performance					
Gain Bandwidth Product	$C_L = 50 \text{pF}, R_L = 2 \text{k}\Omega \text{ to } V_s/2$		1.4		MHz
Phase Margin			73		deg
Gain Margin			12		dB
Slew Rate			1.5		V/µs
Input Voltage Noise	>50kHz		33		nV/√Hz
Crosstalk: LMV358	100kHz		91		dB
LMV324	100kHz		80		dB
DC Performance					
Input Offset Voltage <sup>1</sup>			1	7	mV
Average Drift			6		μV/°C
Input Bias Current <sup>2</sup>			<1		nA
Input Offset Current <sup>2</sup>			<1		nA
Power Supply Rejection Ratio <sup>1</sup>	DC	50	65		dB
Open Loop Gain <sup>1</sup>		50	70		dB
Supply Current (Per Channel) <sup>1</sup>			100	150	μA
Input Characteristics					
Input Common Mode Voltage Range <sup>1</sup>	LO	0	-0.4		V
	Н		3.8	3.6	V
Common Mode Rejection Ratio <sup>1</sup>		50	75		dB
Output Characteristics					
Output Voltage Swing	$R_L = 2k\Omega$ to $V_S/2$ ; LO/HI		0.036 to 4.95		V
	$R_L = 10k\Omega$ to $V_s/2$ ; $LO^1$	0.1	0.013		V
	$R_L = 10k\Omega$ to $V_s/2$ ; $HI^1$		4.98	4.9	V
Short Circuit Output Current <sup>1</sup>	sourcing; V <sub>o</sub> = 0V	5	+34		mA
	sinking; V <sub>0</sub> = 5V	10	-23		mA

Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

#### Notes:

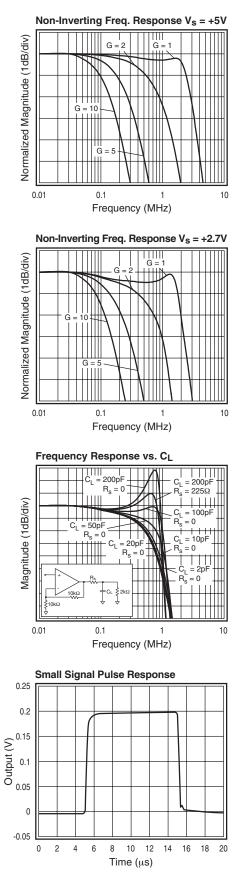
1. Guaranteed by testing or statistical analysis at +25°C.

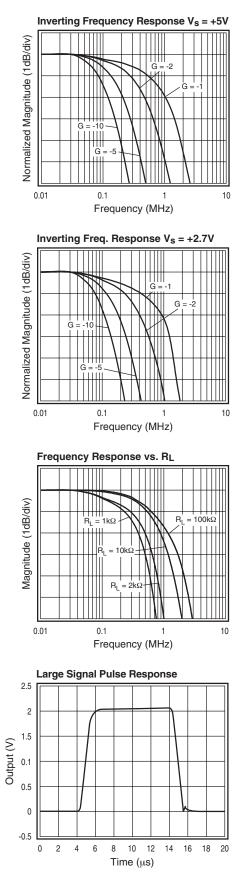
2. +IN and -IN are gates to CMOS transistors with typical input bias current of <1nA. CMOS leakage is too small to practically measure.

# **Package Thermal Resistance**

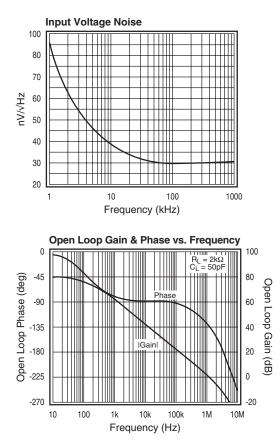
Package	$\theta_{JA}$
5 lead SC70	331.4°C/W
5 lead SOT23	256°C/W
8 lead SOIC	152°C/W
8 lead MSOP	206°C/W
14 lead TSSOP	100°C/W
14 lead SOIC	88°C/W

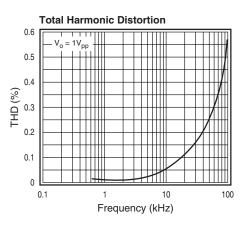
**Typical Operating Characteristics** (T<sub>c</sub> = 25°C, V<sub>s</sub> = +5V, G = 2, R<sub>L</sub> = 10k $\Omega$  to V<sub>s</sub>/2, R<sub>f</sub> = 10k $\Omega$ , V<sub>o (DC)</sub> = V<sub>cc</sub>/2; unless otherwise noted)





**Typical Operating Characteristics** ( $T_c = 25^{\circ}C$ ,  $V_s = +5V$ , G = 2,  $R_L = 10k\Omega$  to  $V_s/2$ ,  $R_f = 10k\Omega$ ,  $V_o$  (DC) =  $V_{cc}/2$ ; unless otherwise noted)





### **Application Information**

### **General Description**

The LMV3XX family are single supply, general purpose, voltage-feedback amplifiers that are pin-for-pin compatible and drop in replacements with other industry standard LMV321, LMV358, and LMV324 amplifiers. The LMV3XX family is fabricated on a CMOS process, features a rail-to-rail output, and is unity gain stable.

The typical non-inverting circuit schematic is shown in

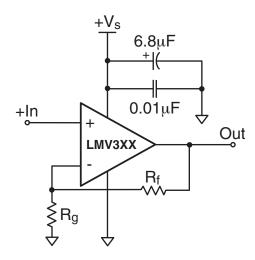




Figure 1: Typical Non-inverting configuration

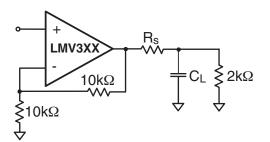
### **Power Dissipation**

The maximum internal power dissipation allowed is directly related to the maximum junction temperature. If the maximum junction temperature exceeds 150°C, some performance degradation will occur. If the maximum junction temperature exceeds 175°C for an extended time, device failure may occur.

### **Driving Capacitive Loads**

The *Frequency Response vs C<sub>L</sub>* plot on page 4, illustrates the response of the LMV3XX family. A small series resistance ( $R_s$ ) at the output of the amplifier, illustrated in Figure 2, will improve stability and settling performance.  $R_s$  values in the *Frequency Response vs C<sub>L</sub>* plot were chosen to achieve maximum bandwidth with less than 1dB of peaking. For maximum flatness, use a larger  $R_s$ . As the plot indicates, the LMV3XX family can easily drive a 200pF capacitive load without a series resistance. For comparison, the plot also shows the LMV321 driving a 200pF load with a 225 $\Omega$  series resistance.

Driving a capacitive load introduces phase-lag into the output signal, which reduces phase margin in the amplifier. The unity gain follower is the most sensitive configuration. In a unity gain follower configuration, the LMV3XX family requires a  $450\Omega$  series resistor to drive a 200pF load. The response is illustrated in Figure 3.



# Figure 2: Typical Topology for driving a capacitive load

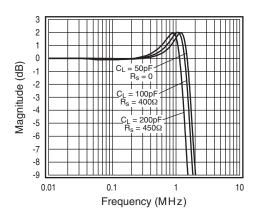


Figure 3: Frequency Response vs C<sub>L</sub> for unity gain configuration

### Layout Considerations

General layout and supply bypassing play major roles in high frequency performance. Fairchild has evaluation boards to use as a guide for high frequency layout and as aid in device testing and characterization. Follow the steps below as a basis for high frequency layout:

- Include 6.8µF and 0.01µF ceramic capacitors
- Place the  $6.8\mu F$  capacitor within 0.75 inches of the power pin
- Place the 0.01µF capacitor within 0.1 inches of the power pin
- Remove the ground plane under and around the part, especially near the input and output pins to reduce parasitic capacitance
- · Minimize all trace lengths to reduce series inductances

Refer to the evaluation board layouts shown in Figure 5 on page 8 for more information.

### **Evaluation Board Information**

The following evaluation boards are available to aid in the testing and layout of this device:

Eval Bd	Description	Products
KEB013	Single Channel, Dual Supply, SOT23-5 for buffer-style pinout	LMV321AS5X
KEB014	Single Channel, Dual Supply, SC70-5 for buffer-style pinout	LMV321AP5X
KEB006	Dual Channel, Dual Supply, 8 lead SOIC	LMV358AM8X
KEB010	Dual Channel, Dual Supply, 8 lead MSOP	LMV358AMU8X
KEB012	Quad Channel, Dual Supply, 14 lead TSSOP	LMV324AMTC14X
KEB018	Quad Channel, Dual Supply, 14 lead SOIC	LMV324AM14X

### **Evaluation Board Schematic Diagrams**

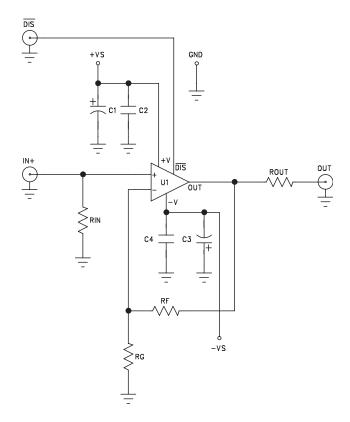
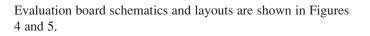
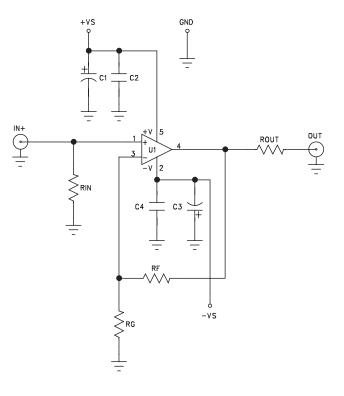


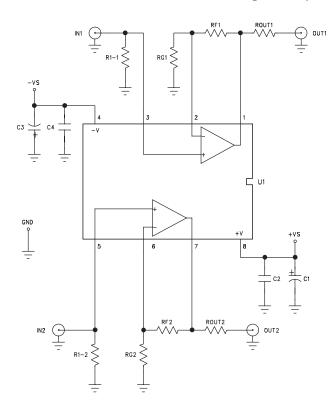
Figure 4a: LMV321 KEB013 schematic







# **Evaluation Board Schematic Diagrams (Continued)**



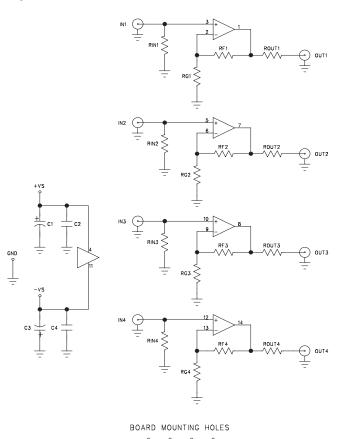


Figure 4c: LMV358 KEB006/KEB010 schematic

# Figure 4d: LMV324 KEB012/KEB018 schematic

# LMV321 Evaluation Board Layout

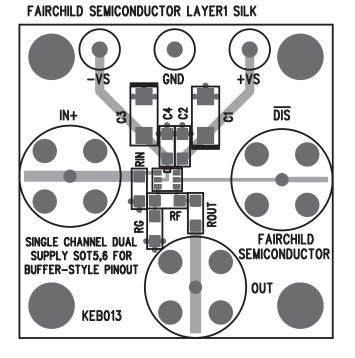


Figure 5a: KEB013 (top side)

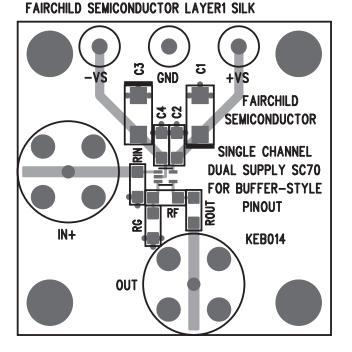
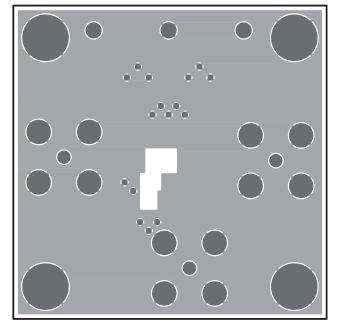
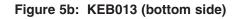


Figure 5c: KEB014 (top side)

#### FAIRCHILD SEMICONDUCTOR LAYER2 SILK





#### FAIRCHILD SEMICONDUCTOR LAYER2 SILK

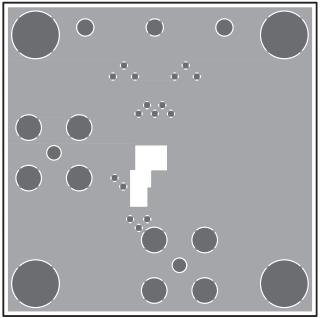


Figure 5d: KEB014 (bottom side)

### LMV358 Evaluation Board Layout



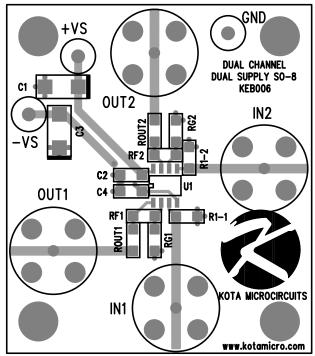


Figure 5e: KEB006 (top side)

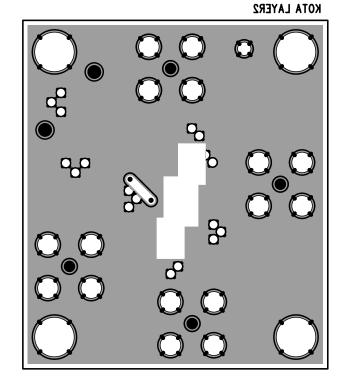


Figure 5f: KEB006 (bottom side)

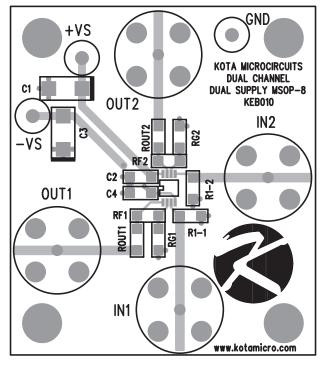


Figure 5g: KEB010 (top side)

**KOTA LAYER2** 

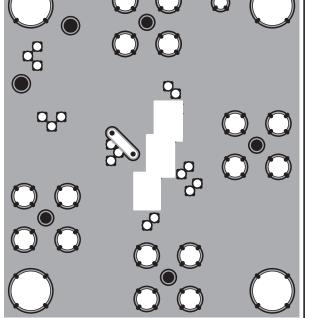


Figure 5h: KEB010 (bottom side)

KOTA LAYER1 SILK

## LMV324 Evaluation Board Layout

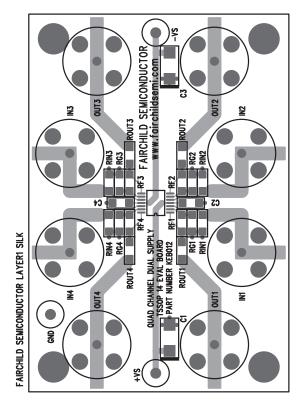


Figure 5i: KEB012 (top side)

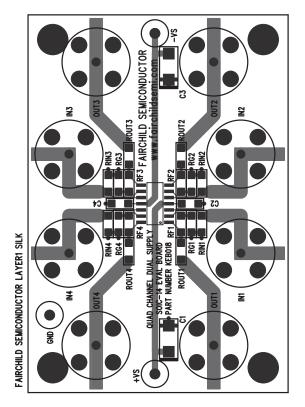


Figure 5k: KEB018 (top side)

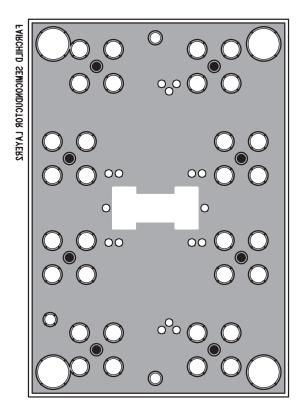
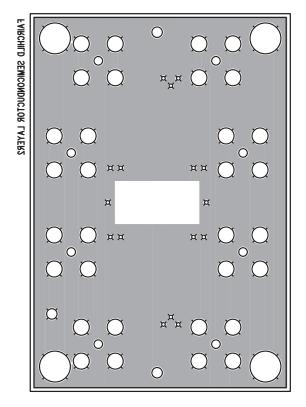


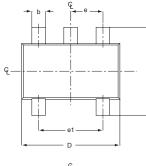
Figure 5j: KEB012 (bottom side)

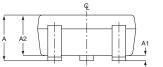


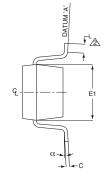


# LMV321 Package Dimensions

SOT23-5







SYMBOL	MIN	MAX	
A	0.90	1.45	
A1	0.00	0.15	
A2	0.90	1.30	
b	0.25	0.50	
С	0.09	0.20	
D	2.80	3.10	
E	2.60	3.00	
E1	1.50	1.75	
L	0.35	0.55	
е	0.95 ref		
e1	1.90 ref		
α	0°	10°	

#### NOTE:

NOTE:

All dimensions are in millimeters.
Foot length measured reference to flat foot surface parallel to DATUM 'A' and lead surface.
Package outline exclusive of mold flash & metal burr.
Package outline inclusive of solder plating.
Comply to EIAJ SC74A.
Package ST 0003 REV A supercedes SOT-D-2005 REV C.

• 1

SYMBOL

b F HE Q1 A2 A1

А

С

MIN MAX 0.65 BSC

SC 2.20 0.30 1.35 2.40 0.40 1.00 0.10 1.10

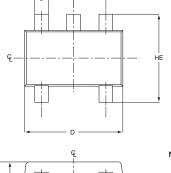
1.10 0.18

0.30

0.65 1.80 0.15 1.15 1.80 0.10 0.80 0.00 0.80

0.80
0.10
1.10

### **SC70**



A1 ↓

A2

**≁**C

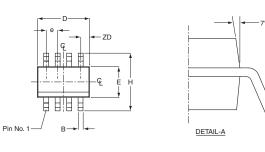
Ģ

Q1 →

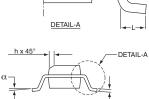
NOTE: 1. All dimensions are in millimeters. 2. Dimensions are inclusive of plating. 3. Dimensions are exclusive of mold flashing and metal burr. 4. All speccifications comply to EIAJ SC70.

### LMV358 Package Dimensions

#### SOIC







· C



SYMBOL

A1

В

C

F

e Н

h

#### NOTE:

1. All dimensions are in millimeters. All dimensions are in millimeters.
 Lead coplanarity should be 0 to 0.10mm (.004\*) max.
 Package surface finishing: (2.1) Top: matte (charmilles #18-30). (2.2) All sides: matte (charmilles #18-30). (2.3) Bottom: smooth or matte (charmilles #18-30).

SOIC-8

**MIN** 0.10

0.36

0.19

4.80

3.81

5.80

0.25

0.41

1.52

0°

1.37

1.27 BSC

0.53 ref

MAX 0.25

0.46

0.25

4.98

3.99

6.20

0.50

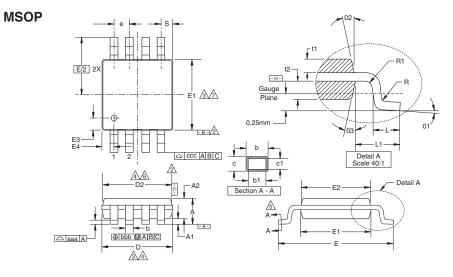
1.27

1.72

8

1.57

- All dimensions excluding mold flashes and end flash 4.
- from the package body shall not exceed o.152mm (.006) per side(d).



#### NOTE:

1 All dimensions are in millimeters (angle in degrees), unless otherwise specified.

Datums -B- and -C- to be determined at datum plane -H-.

Dimensions "D" and "E1" are to be determined at datum EH-.

A Dimensions "D2" and "E2" are for top package and dimensions "D" and "E1" are for bottom package.

 $\underline{\land}$  Cross sections A – A to be determined at 0.13 to 0.25mm from the leadtip.

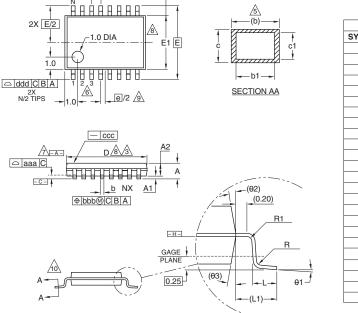
A Dimension "D" and "D2" does not include mold flash, protrusion or gate burrs.

Dimension "E1" and "E2" does not include interlead flash or protrusion.

MSOP-8				
SYMBOL	MIN	MAX		
A	1.10	-		
A1	0.10	±0.05		
A2	0.86	±0.08		
D	3.00	±0.10		
D2	2.95	±0.10		
E	4.90	±0.15		
E1	3.00	±0.10		
E2	2.95	±0.10		
E3	0.51	±0.13		
E4	0.51	±0.13		
R	0.15	+0.15/-0.06		
R1	0.15	+0.15/-0.06		
t1	0.31	±0.08		
t2	0.41	±0.08		
b	0.33	+0.07/-0.08		
b1	0.30	±0.05		
С	0.18	±0.05		
c1	0.15	+0.03/-0.02		
01	3.0°	±3.0°		
02	12.0°	±3.0°		
03	12.0°	±3.0°		
L	0.55	±0.15		
L1	0.95 BSC	-		
aaa	0.10	-		
bbb	0.08	-		
CCC	0.25	-		
е	0.65 BSC	-		
S	0.525 BSC	-		

### LMV324 Package Dimensions

#### TSSOP



-в-А

e

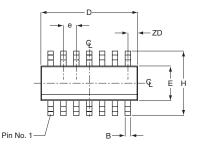
TSSOP-14							
SYMBOL	SYMBOL MIN NOM MAX						
A	-	- 1.10					
A1	0.05	.05 - 0.15					
A2	0.85	0.90	0.95				
L	0.50	0.60	0.75				
R	0.09	-	-				
R1	0.09	-	-				
b	0.19	-	0.30				
b1	0.19	0.22	0.25				
С	0.09	-	0.20				
c1	0.09	0.16					
<del>0</del> 1	0°	-	8°				
L1	1.0 REF						
aaa	0.10						
bbb		0.10					
CCC		0.05					
ddd		0.20					
е		0.65 BSC					
<del>0</del> 2		12° REF					
<del>0</del> 3		12° REF					
D	4.90	5.00	5.10				
E1	4.30	4.40	4.50				
E		6.4 BSC					
е	0.65 BSC						
N	14						

#### NOTES:

- 1 All dimensions are in millimeters (angle in degrees).
- 2 Dimensioning and tolerancing per ASME Y14.5-1994.
- 🖄 Dimensions "D" does not include mold flash, protusions or gate burrs. Mold flash protusions or gate burrs shall not exceed 0.15 per side .
- A Dimension "E1" does not include interlead flash or protusion. Interlead flash or protusion shall not exceed 0.25 per side.
- Dimension "b" does not include dambar protusion. Allowable dambar protusion shall be 0.08mm total in excess of the "b" dimension at maximum material condition. Dambar connot be located on the lower radius of the foot. Minimum space between protusion and adjacent lead is 0.07mm for 0.5mm pitch packages.
- A Terminal numbers are shown for reference only.
- $\triangle$  Datums -A- and -B- to be determined at datum plane -H-.
- $\underline{\&}$  Dimensions "D" and "E1" to be determined at datum plane  $\underline{-H-}$ .
- This dimensions applies only to variations with an even number of leads per side. For variation with an odd number of leads per side, the "center" lead must be coincident with the package centerline, Datum A.

Cross sections A – A to be determined at 0.10 to 0.25mm from the leadtip.

#### SOIC



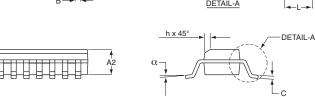


	3010-14	
SYMBOL	MIN	MAX
A1	.0040	.0098
В	.014	.018
С	.0075	.0098
D	.337	.344
E	.150	.157
е	.050	BSC
Н	.2284	.2440
h	.0099	.0196
L	.016	.050
A	.060	.068
	0°	8°
ZD	0.20	) ref
A2	.054	.062

SOIC-14

#### NOTE:

- 1. All dimensions are in inches.
- 2. Lead coplanarity should be 0 to 0.10mm (.004") max.
- Package surface finishing: (2.1) Top: matte (charmilles #18~30).
   (2.2) All sides: matte (charmilles #18.30)
- (2.2) All sides: matte (charmilles #18~30).
  (2.3) Bottom: smooth or matte (charmilles #18~30).
  4. All dimensions excluding mold flashes and end flash
- from the package body shall not exceed 0.152mm (.006) per side (d).



### **Ordering Information**

Model	Part Number	Package	Container	Pack Qty
LMV321	LMV321AP5X	SC70-5	Reel	3000
LMV321	LMV321AS5X	SOT23-5	Reel	3000
LMV358	LMV358AM8X	SOIC-8	Reel	2500
LMV358	LMV358AMU8X	MSOP-8	Reel	3000
LMV324	LMV324AMTC14X	TSSOP	Reel	2500
LMV324	LMV324AM14X	SOIC	Reel	2500

Temperature range for all parts: -40°C to +125°C.

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- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.